

SHEET 1 OF 1

INFORMATION DISCLOSURE  
CITATION IN AN  
APPLICATION

(PTO-1449)

ATTY. DOCKET NO.  
57454-982SERIAL NO.  
10/686,766APPLICANT  
Tadatoshi SUZUKI, et al.FILING DATE  
October 17, 2003GROUP  
3748

## U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code <sup>2</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
JC ↓		US 6,224,688 B1	05/01/2001	Takemura et al.	
		US 5,811,250	03/18/1997	Narai et al.	
		US 6,440,232 B1	08/27/2002	Takemura et al.	
		US 5,458,138	10/10/1995	Yamashita et al.	
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		US 5,427,457	06/27/1995	Furumura et al.	
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		US			
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## FOREIGN PATENT DOCUMENTS

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						Yes	No
JC ↓		EP 0 950 723 A1	10/20/1999	KOMATSU LTD.			
		GB 2 258 274 A	02/03/1993	NSK LTD.			
		EP 0 811 788 A1	12/10/1997	KOYO SEIKO CO., LTD.			

## OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.

EXAMINER

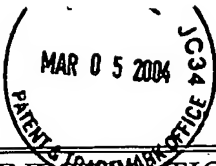
*James Corrigan*

DATE CONSIDERED

12-12-04

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.



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JC ↓	A1	EP 0 811 789	12/10/1997	Koyo Seiko Co., Ltd.			
	A1	EP 0 950 723	10/20/1999	Komatsu Ltd.			
	A	GB 2 258 274	02/03/1993	NSK Ltd.			
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EXAMINER <i>Jamie Corrigan</i>				DATE CONSIDERED <i>12-12-04</i>			

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		US					
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						Yes	No
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		JP 10-47334	02/17/1998	NIPPON SEIKO KK			JAPAN (w/English Abstract)
		JP 10-103339	04/21/1998	KOYO SEIKO CO LTD			JAPAN (w/English Abstract)
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✓		JP 2000-205284	07/25/2000	KOYO SEIKO CO LTD			JAPAN (w/English Abstract)
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		JIS G 0551 "Methods of austenite grain size determination for steel", Japanese Standard Association, February 20, 1998					
		JIS Z 2242 "Method of impact test for metallic materials", Japanese Standard Association December 21, 1998					
		JIS Z 2202 "Test pieces for impact test for metallic materials", Japanese Standard Association, February 20, 1998					
EXAMINER <i>Jamie Corrigan</i>				DATE CONSIDERED <i>12-12-04</i>			

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